100V, 137A, 4.5 mΩ N-channel Power SGT MOSFET

JMSL1004TG

Features

- $\bullet \quad \text{Excellent $R_{\text{DS(ON)}}$ and Low Gate Charge}$
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

Applications

- Load Switch
- PWM Application
- Power Management

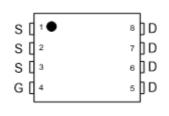
Product Summary

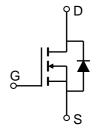
Parameters	Value	Unit
V_{DSS}	100	V
$V_{GS(th)_Typ}$	1.7	V
I _D (@V _{GS} =10V)	137	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	3.3	mΩ
$R_{DS(ON)_Typ}(@V_{GS}=4.5V$	4.5	mΩ











PDFN5X6-8L

Pin Assignment

Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL1004TG-13	SL1004T	1	Tape&Reel	PDFN5x6-8L	5000	50000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		100	V
V_{GS}	Gate-to-Source Voltage		±20	V
I _D	Continuous Drain Current	$T_C = 25^{\circ}C$	137	А
ıD		$T_C = 100$ °C	87	
I _{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energy	/ ⁽²⁾	497	mJ
P _D	LOWER I RECIPATION	$T_C = 25^{\circ}C$	141	W
		$T_C = 100$ °C	57	V V
T_{J}, T_{STG}	Junction & Storage Temperature R	ange	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	44	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.9	C/VV



Electrical Characteristics (T_J = 25°C unless otherwise specified)

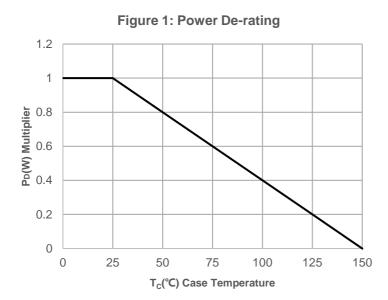
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics	· ·				
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80 \text{V}, V_{GS} = 0 \text{V}$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics	•		•		•
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.4	1.7	2.2	V
D	(4)	$V_{GS} = 10V, I_D = 20A$	-	3.3	4.3	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 4.5V, I_D = 20A$	-	4.5	5.8	mΩ
Dynami	c Characteristics					
R_g	Gate Resistance	f = 1MHz	-	1.6	-	Ω
C_{iss}	Input Capacitance	.,	3740	5236	7069	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 50V,$ f = 1MHz	1086	1521	2053	pF
C_{rss}	Reverse Transfer Capacitance	1 - 11/11/2	13	18	25	pF
Qg	Total Gate Charge		55	77	104	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 50V, I_{D} = 20A$	13	18	24	nC
Q_{gd}	Gate Drain("Miller") Charge	= V _{DS} = 30V, I _D = 20A	8	12	16	nC
Switchi	ng Characteristics				ı	ı
$t_{d(on)}$	Turn-On DelayTime	_	-	16	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 50V$	-	23	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_D = 20A, R_{GEN} = 3\Omega$	-	57	-	ns
t_f	Turn-Off Fall Time		-	16	-	ns
Body D	iode Characteristics					
I _S	Maximum Continuous Body Diode Forward Current		-	-	137	Α
I_{SM}	Maximum Pulsed Body Diode Forward Cur	rent	-	-	549	А
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	L = 20A di/dt = 100A/vs	74	103	139	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 20A$, di/dt = 100A/us	-	104	-	nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- $2.~E_{AS}~condition:~Starting~T_J=25C,~V_{DD}=50V,~V_{GS}=10V,~R_G=25ohm,~L=3mH,~I_{AS}=18.2A,~V_{DD}=0V~during~time~in~avalanche.$
- 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.
- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 0.5%.



Typical Performance Characteristics



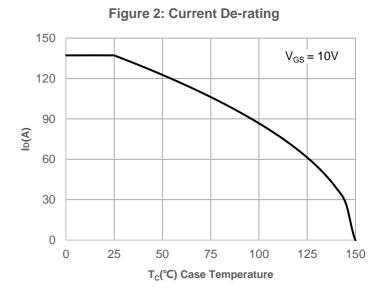
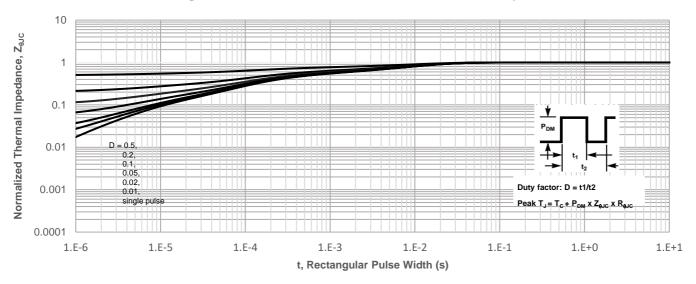


Figure 3: Normalized Maximum Transient Thermal Impedance



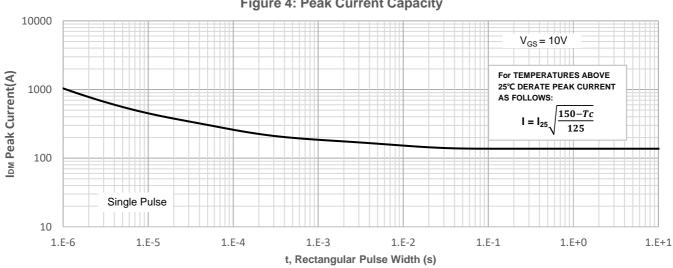


Figure 4: Peak Current Capacity



Typical Performance Characteristics

Figure 5: Output Characteristics

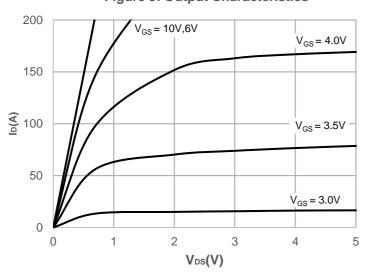


Figure 6: Typical Transfer Characteristics

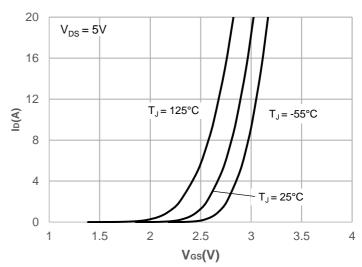


Figure 7: On-resistance vs. Drain Current

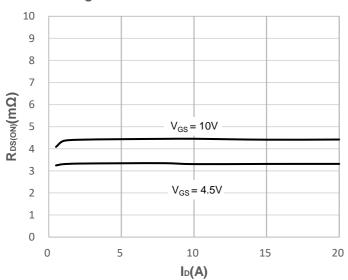


Figure 8: Body Diode Characteristics

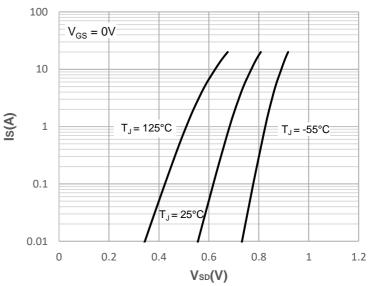


Figure 9: Gate Charge Characteristics

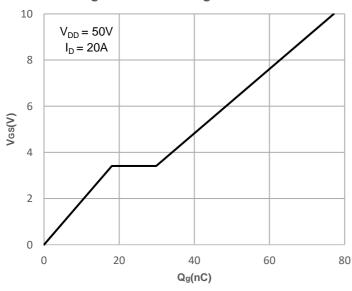
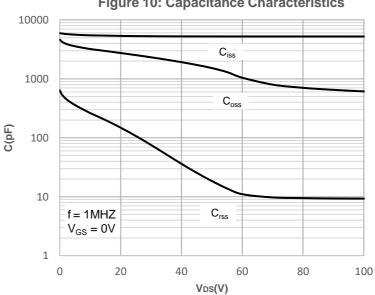


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

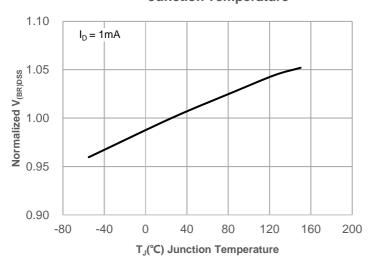


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

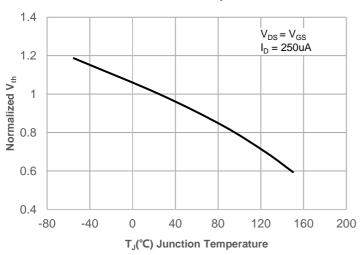


Figure 15: Maximum Safe Operating Area

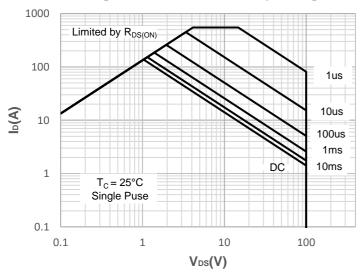
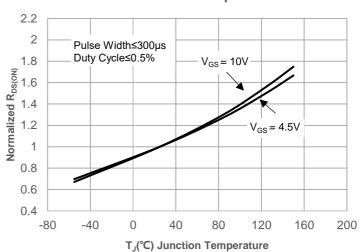
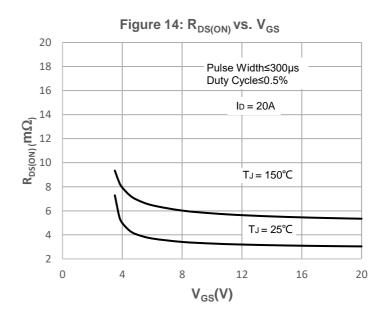


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

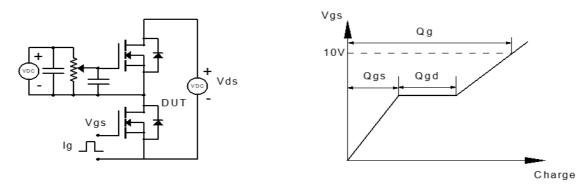


Figure 1: Gate Charge Test Circuit & Waveform

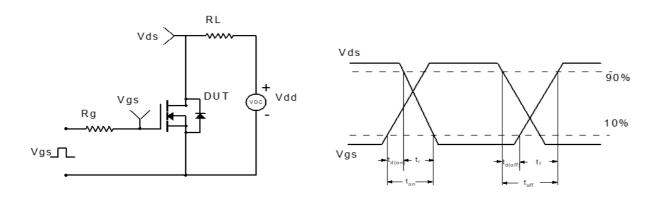


Figure 2: Resistive Switching Test Circuit & Waveform

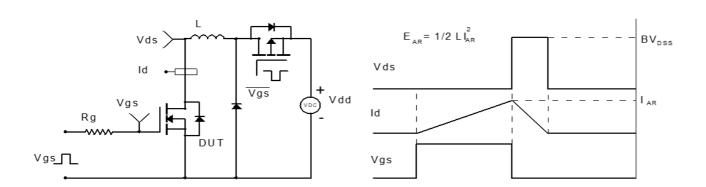


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

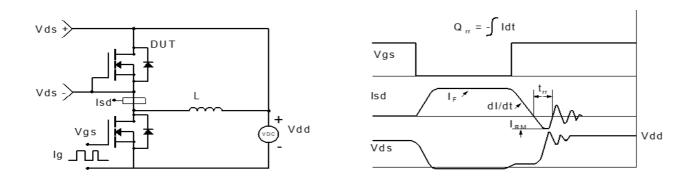
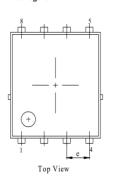


Figure 4: Diode Recovery Test Circuit & Waveform

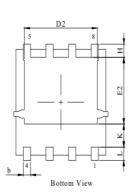


Package Mechanical Data(PDFN5X6-8L)

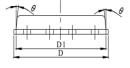
Package Outline







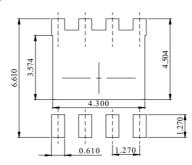
DTV	MILLIMETER				
DIM.	MIN.	NOM.	MAX.		
A	0. 9	1	1. 15		
b	0.31	0.41	0. 51		
С	0. 24	0.32	0.4		
D	5	5. 2	5. 4		
D1	4. 95	5. 05	5. 15		
D2	4	4. 1	4. 2		
E	6.05	6. 15	6. 25		
El	5. 5	5. 6	5. 7		
E2	3. 42	3, 53	3. 63		
е	1. 27BSC				
Н	0.6	0. 7	0.8		
L	0.5	0.7	0.8		
K	1.23 REF				
0			10		



Front View

- Dimension and tolerance per ASME Y14.5M, 1994.
 All dimensions in millimeter (angle in degree).
 Dimensions D1 and E1 do not include mold flash protrusions or gate burrs.

Recommended Soldering Footprint



DIMENSIONS:MILLIMETERS

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